## MOSFET – Dual, P-Channel, Trench Small Signal, ESD Protected, SC-88 20 V, 0.88 A

#### **Features**

- Leading Trench Technology for Low R<sub>DS(ON)</sub> Performance
- Small Footprint Package (SC70-6 Equivalent)
- ESD Protected Gate
- NV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These are Pb-Free Devices

#### **Applications**

- Load/Power Management
- Charging Circuits
- Load Switching
- Cell Phones, Computing, Digital Cameras, MP3s and PDAs

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

,						
Param	Symbol	Value	Unit			
Drain-to-Source Voltage			$V_{DSS}$	-20	V	
Gate-to-Source Voltage	)		$V_{GS}$	±12	V	
Continuous Drain	Steady	T <sub>A</sub> = 25°C	I <sub>D</sub>	-0.88	Α	
Current (Note 1)	State	T <sub>A</sub> = 85°C		-0.63		
Power Dissipation	Steady	T <sub>A</sub> = 25°C	$P_{D}$	0.272	W	
(Note 1)	State	T <sub>A</sub> = 85°C		0.141		
Continuous Drain	t ≤ 5 s	T <sub>A</sub> = 25°C	I <sub>D</sub>	-1.0	Α	
Current (Note 2)		T <sub>A</sub> = 85°C		-0.72		
Power Dissipation	t ≤ 5 s	T <sub>A</sub> = 25°C	$P_{D}$	0.35	W	
(Note 2)		T <sub>A</sub> = 85°C		0.181		
Pulsed Drain Current t ≤ 10 μs			I <sub>DM</sub>	±3.0	Α	
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>STG</sub>	–55 to 150	°C	
Continuous Source Current (Body Diode)			I <sub>S</sub>	-0.48	Α	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C	

#### THERMAL RESISTANCE RATINGS (Note 1)

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State	$R_{\theta JA}$	460	°C/W
Junction-to-Ambient - t ≤ 5 s	$R_{\theta JA}$	357	
Junction-to-Lead - Steady State	$R_{\theta JL}$	226	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

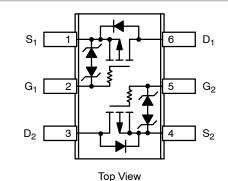
 Surface mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces), steady state.



#### ON Semiconductor®

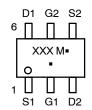
#### www.onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> Typ	I <sub>D</sub> Max
-20 V	215 mΩ @ -4.5 V	
	345 mΩ @ –2.5 V	-0.88 A
	600 mΩ @ –1.8 V	



# MARKING DIAGRAM & PIN ASSIGNMENT





XXX = Device Code

M = Date Code

Pb-Free Package

(Note: Microdot may be in either location)

#### ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

2.	Surface mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces), $t \le 5$ s.

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub>=25°C unless otherwise stated)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		-20			V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = -16 V	T <sub>J</sub> = 25°C			-1.0	μΑ
		$V_{GS} = 0 \text{ V}, V_{DS} = -16 \text{ V}$	T <sub>J</sub> = 125°C		-1.0	-5.0	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = 3	±4.5 V		0.03	1.0	μΑ
		V <sub>DS</sub> = 0 V, V <sub>GS</sub> = :	±12 V		6.0		
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = -2$	250 μA	-0.45		-1.2	V
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS} = -4.5 \text{ V}, I_D = -4.5 \text{ V}$	-0.88 A		215	260	mΩ
		$V_{GS} = -2.5 \text{ V}, I_D = -2.5 \text{ V}$	-0.71 A		345	500	1
		V <sub>GS</sub> = -1.8 V, I <sub>D</sub> = -	-0.20 A		600	1000	
Forward Transconductance	9FS	V <sub>DS</sub> = -10 V, I <sub>D</sub> = -0.88 A			3.0		S
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>ISS</sub>	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = -20 \text{ V}$			155		pF
Output Capacitance	Coss				25		1
Reverse Transfer Capacitance	C <sub>RSS</sub>				18		1
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = -4.5 V, V <sub>DS</sub> = -10 V, I <sub>D</sub> = -0.88 A			2.2		nC
Gate-to-Source Charge	$Q_{GS}$				0.5		1
Gate-to-Drain Charge	$Q_{GD}$	10 = 0.0071			0.65		1
SWITCHING CHARACTERISTICS (No	ote 4)				•	•	
Turn-On Delay Time	t <sub>d(ON)</sub>				5.8		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = -4.5 V, V <sub>DD</sub> =	-10 V,		6.5		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$V_{GS} = -4.5 \text{ V}, V_{DD} = -10 \text{ V},$ $I_{D} = -0.5 \text{ A}, R_{G} = 20 \Omega$			13.5		1
Fall Time	t <sub>f</sub>				3.5		1
DRAIN-SOURCE DIODE CHARACTE	RISTICS		•		•	-	•
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V.	T <sub>J</sub> = 25°C		-0.8	-1.2	V
		$V_{GS} = 0 \text{ V},$ $I_{S} = -0.48 \text{ A}$ $T_{J} = 125^{\circ}\text{C}$			-0.66		1

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Pulse Test: pulse width ≤ 300µs, duty cycle ≤ 2%.

4. Switching characteristics are independent of operating junction temperatures.

#### TYPICAL PERFORMANCE CURVES (T<sub>J</sub> = 25°C unless otherwise noted)

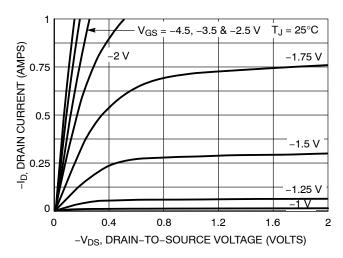


Figure 1. On-Region Characteristics

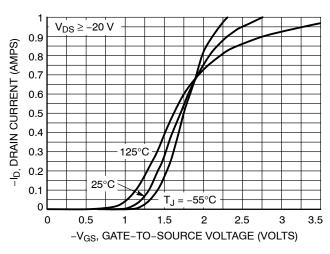


Figure 2. Transfer Characteristics

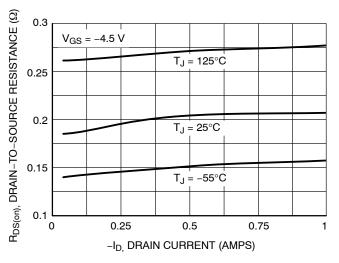


Figure 3. On-Resistance vs. Drain Current and Temperature

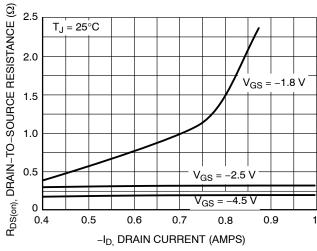


Figure 4. On–Resistance vs. Drain Current and Gate Voltage

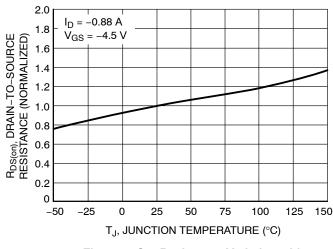


Figure 5. On–Resistance Variation with Temperature

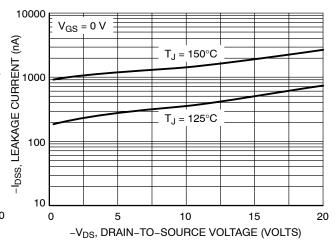
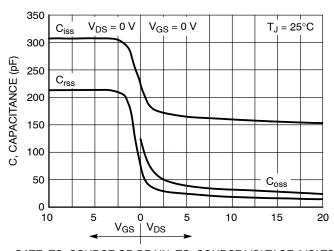


Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### TYPICAL PERFORMANCE CURVES (T<sub>J</sub> = 25°C unless otherwise noted)



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation

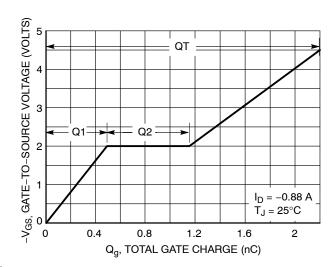


Figure 8. Gate-to-Source Voltage vs. Total
Gate Charge

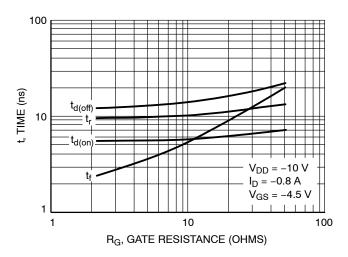


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

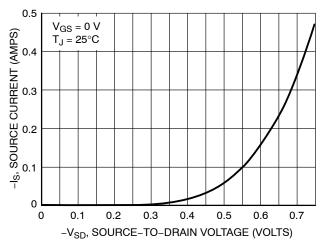


Figure 10. Diode Forward Voltage vs. Current

#### **ORDERING INFORMATION**

Device	Marking	Package	Shipping <sup>†</sup>	
NTJD4152PT1G	TK			
NTJD4152PT2G	TK	SC-88 (Pb-Free)	3000 / Tape & Reel	
NVJD4152PT1G*	VTK	, ,		

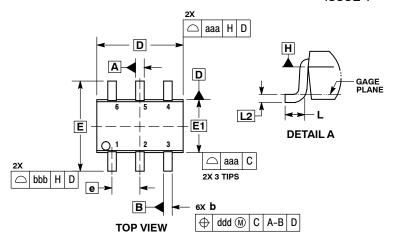
<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

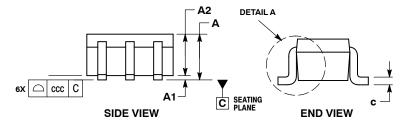
<sup>\*</sup>NV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable.

#### PACKAGE DIMENSIONS

### SC-88/SC70-6/SOT-363

CASE 419B-02 **ISSUE Y** 





- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- CONTROLLING DIMENSION: MILLIMETERS.
  DIMENSIONS D AND E1 DO NOT INCLUDE MOLD FLASH,
- PROTRUSIONS, OR GATE BURRS. MOLD FLASH, PROTRU-SIONS, OR GATE BURRS SHALL NOT EXCEED 0.20 PER END.
- DIMENSIONS D AND E1 AT THE OUTERMOST EXTREMES OF
- THE PLASTIC BODY AND DATUM H.

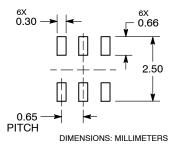
  DATUMS A AND B ARE DETERMINED AT DATUM H.

  DIMENSIONS b AND CAPPLY TO THE FLAT SECTION OF THE

  LEAD BETWEEN 0.08 AND 0.15 FROM THE TIP.
- DIMENSION 5 DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 TOTAL IN EXCESS OF DIMENSION 6 AT MAXIMUM MATERIAL CONDITION. THE DAMBAR CANNOT BE LOCATED ON THE LOWER RADIUS OF THE FOOT.

	MILLIMETERS			INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α			1.10			0.043	
A1	0.00		0.10	0.000		0.004	
A2	0.70	0.90	1.00	0.027	0.035	0.039	
b	0.15	0.20	0.25	0.006	0.008	0.010	
С	0.08	0.15	0.22	0.003	0.006	0.009	
D	1.80	2.00	2.20	0.070	0.078	0.086	
E	2.00	2.10	2.20	0.078	0.082	0.086	
E1	1.15	1.25	1.35	0.045	0.049	0.053	
е	0.65 BSC			0.026 BSC			
L	0.26	0.36	0.46	0.010 0.014 0.		0.018	
L2	0.15 BSC			0.006 BSC			
aaa	0.15			0.006			
bbb	0.30			0.012			
ccc	0.10			0.004			
ddd	0.10 0.004						

#### RECOMMENDED **SOLDERING FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

STYLE 26: PIN 1. SOURCE 1 2. GATE 1 3. DRAIN 2 4. SOURCE 2

5. GATE 2 DRAIN 1

ON Semiconductor and the unarregistered trademarks of Semiconductor Components Industries, LLC (SCILLC) or its subsidiaries in the United States and/or other countries. SCILLC owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of SCILLC's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. SCILLC reserves the right to make changes without further notice to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights nor the rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

#### **PUBLICATION ORDERING INFORMATION**

#### LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor P.O. Box 5163, Denver, Colorado 80217 USA

Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com

N. American Technical Support: 800-282-9855 Toll Free USA/Canada

Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910 Japan Customer Focus Center

Phone: 81-3-5817-1050

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative

### **X-ON Electronics**

Largest Supplier of Electrical and Electronic Components

Click to view similar products for MOSFET category:

Click to view products by ON Semiconductor manufacturer:

Other Similar products are found below:

614233C 648584F MCH3443-TL-E MCH6422-TL-E FDPF9N50NZ FW216A-TL-2W FW231A-TL-E APT5010JVR NTNS3A92PZT5G IRF100S201 JANTX2N5237 2SK2464-TL-E 2SK3818-DL-E FCA20N60\_F109 FDZ595PZ STD6600NT4G FSS804-TL-E 2SJ277-DL-E 2SK1691-DL-E 2SK2545(Q,T) D2294UK 405094E 423220D MCH6646-TL-E TPCC8103,L1Q(CM 367-8430-0972-503 VN1206L 424134F 026935X 051075F SBVS138LT1G 614234A 715780A NTNS3166NZT5G 751625C 873612G IRF7380TRHR IPS70R2K0CEAKMA1 RJK60S3DPP-E0#T2 RJK60S5DPK-M0#T0 APT5010JVFR APT12031JFLL APT12040JVR DMN3404LQ-7 NTE6400 JANTX2N6796U JANTX2N6784U JANTXV2N5416U4 SQM110N05-06L-GE3 SIHF35N60E-GE3